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### N-Channel 700V (D-S) Super Junction Power MOSFET

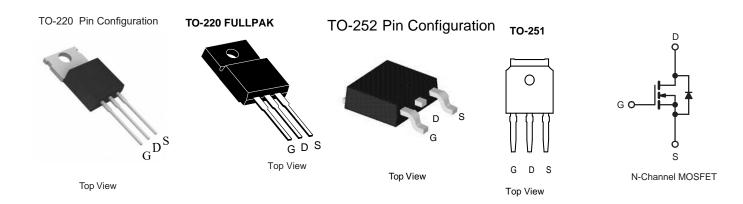
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	700					
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	2.4				
Q <sub>g</sub> (Max.) (nC)	30					
Q <sub>gs</sub> (nC)	4.5					
Q <sub>gd</sub> (nC)	16					
Configuration	Single					

#### **FEATURES**

- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- · Lead (Pb)-free Available







ABSOLUTE MAXIMUM RATINGS T	<sub>C</sub> = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	700	v	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	2.0		
		$T_C = 100 ^{\circ}C$		1.5	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	10	1	
Linear Derating Factor				0.27	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	250	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	2.3	A	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	3.4	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	PD	34	W	
Peak Diode Recovery dV/dtc			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		-	300 <sup>d</sup>	1	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 73 mH,  $R_G = 25 \Omega$ ,  $I_{AS} = 1.5$  A (see fig. 12).

c.  $I_{SD} \le 1.6$  A, dl/dt  $\le 60$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply



## DTP2N70SJ/DTP2N70FSJ/DTU2N70SJ/DTL2N70SJ www.din-tek.jp

THERMAL RESISTANCE RAT	rings							
PARAMETER	SYMBOL	ТҮР	TYP. MAX.			UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 65			°C/W			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 3.6				0,11		
<b>SPECIFICATIONS</b> $T_J = 25 \ ^{\circ}C$ ,	unless otherv	vise noted						
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNI
Static								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 2	50 µA	700	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.62	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 2	250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	$V_{GS} = \pm 20 V$			-	± 100	nA
	I <sub>DSS</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = 700 V, V <sub>GS</sub> = 0 V			-	100	μΑ
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 480 V	$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$			-	500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub>	= 1.5 A <sup>b</sup>	-	2.4	-	Ω
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> =	1.5 A <sup>b</sup>	2.2	-	-	S
Dynamic								
Input Capacitance	Ciss		<u>м</u> о <u>м</u>		-	656	-	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 V, V_{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz$		-	85	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	19	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg				-	-	31	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		N, V <sub>DS</sub> = 360 V, g. 6 and 13 <sup>b</sup>	-	-	4.6	nC
Gate-Drain Charge	Q <sub>gd</sub>	see fig. e		g. o and to	-	-	17	
Turn-On Delay Time	t <sub>d(on)</sub>				-	11	-	
Rise Time	t <sub>r</sub>		$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 1.6 \text{ A},$		-	13	-	1
Turn-Off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 12 Ω, R <sub>D</sub> = 82 Ω, see fig. 10 <sup>b</sup>		-	35	-	ns	
Fall Time	t <sub>f</sub>				-	14		-
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-		
Drain-Source Body Diode Characteristic	S						1	1
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	2.0	- A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode			-	-		10
Body Diode Voltage	$V_{SD}$	$T_J = 25 \ ^{\circ}C, \ I_S = 1.5 \ A, \ V_{GS} = 0 \ V^b$			-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			-	400	810	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 1.6 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$			-	2.1	4.2	μΟ
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time i	s negligible (turn	on is don	ninated by	L <sub>S</sub> and I	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

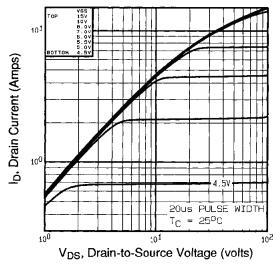
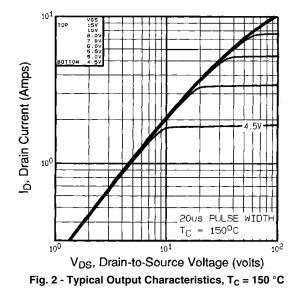
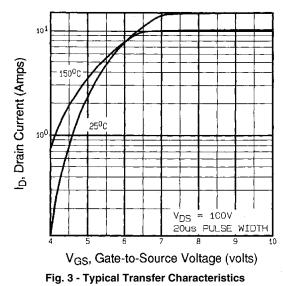


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C





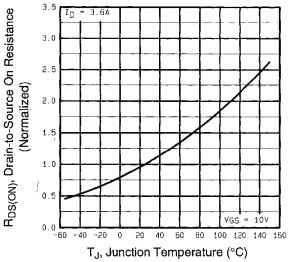
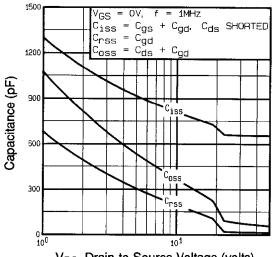


Fig. 4 - Normalized On-Resistance vs. Temperature



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V<sub>DS</sub>, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

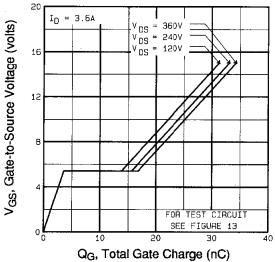


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

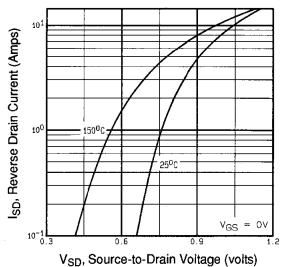
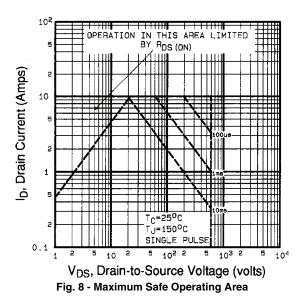


Fig. 7 - Typical Source-Drain Diode Forward Voltage





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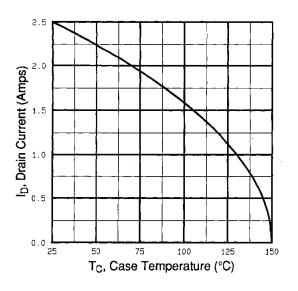


Fig. 9 - Maximum Drain Current vs. Case Temperature

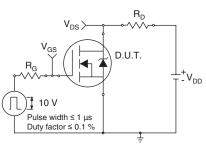


Fig. 10a - Switching Time Test Circuit

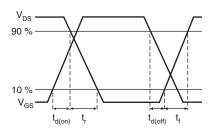
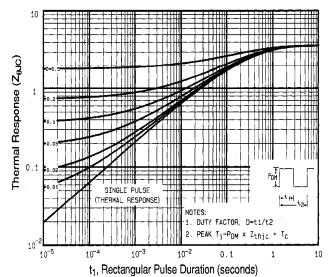


Fig. 10b - Switching Time Waveforms





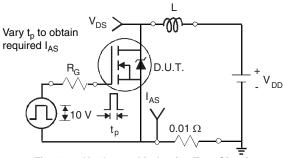


Fig. 12a - Unclamped Inductive Test Circuit

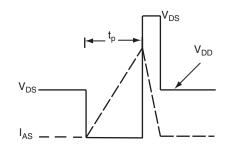


Fig. 12b - Unclamped Inductive Waveforms



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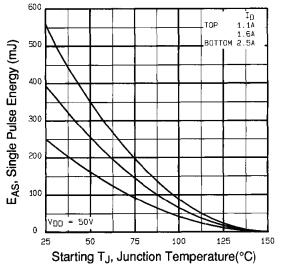


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

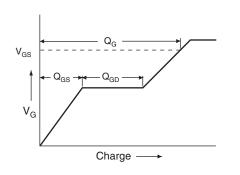


Fig. 13a - Basic Gate Charge Waveform

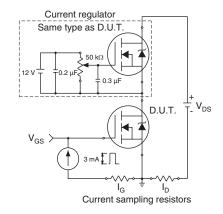
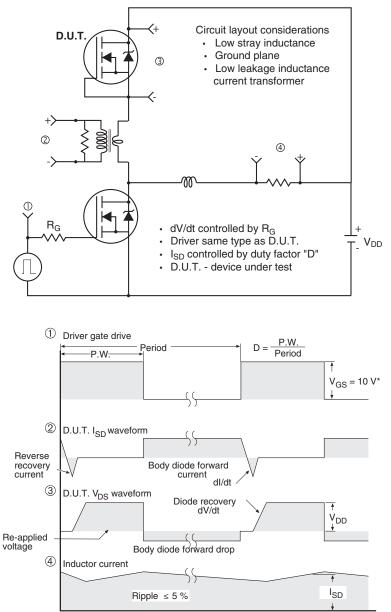


Fig. 13b - Gate Charge Test Circuit



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\*  $V_{GS}$  = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel



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